# **Power MOSFET**

# -12 V, -4.3 A, μCOOL™ Dual P-Channel, 2x2 mm, WDFN package

### **Features**

- WDFN 2x2 mm Package with Exposed Drain Pads for Excellent Thermal Conduction
- Lowest RDS(on) in 2x2 mm Package
- Footprint Same as SC-88 Package
- Low Profile (<0.8 mm) for Easy Fit in Thin Environments
- Bidirectional Current Flow with Common Source Configuration
- These are Pb-Free Devices

### **Applications**

- Optimized for Battery and Load Management Applications in Portable Equipment
- Li Ion Battery Charging and Protection Circuits
- Dual High Side Load Switch

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltag	$V_{DSS}$	-12	V		
Gate-to-Source Voltage	)		$V_{GS}$	±8.0	V
Continuous Drain	Steady	$T_J = 25^{\circ}C$	I <sub>D</sub>	-3.5	Α
Current (Note 1)	State	T <sub>J</sub> = 85°C		-2.5	
	t ≤ 5 s	$T_J = 25^{\circ}C$		-4.3	
Power Dissipation (Note 1)	Steady State	T <sub>J</sub> = 25°C	P <sub>D</sub>	1.5	W
	t ≤ 5 s	]		2.3	
Continuous Drain		$T_J = 25^{\circ}C$	I <sub>D</sub>	-2.4	Α
Current (Note 2)	Steady	T <sub>J</sub> = 85°C		-1.7	
Power Dissipation (Note 2)	State	T <sub>J</sub> = 25°C	P <sub>D</sub>	0.7	W
Pulsed Drain Current	t <sub>p</sub> =	10 μs	I <sub>DM</sub>	-20	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C
Source Current (Body D	I <sub>S</sub>	-1.5	Α		
	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)				°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

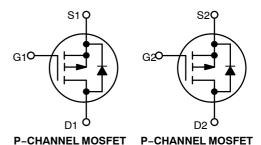
- 1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- 2. Surface Mounted on FR4 Board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz. Cu.



## ON Semiconductor®

### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
-12 V	60 mΩ @ -4.5 V	-3.0 A
	85 mΩ @ –2.5 V	-3.0 A
	110 mΩ @ –1.8 V	-0.7 A
	140 mΩ @ –1.5 V	-0.5 A
	190 mΩ @ –1.3 V	-0.2 A
	230 mΩ @ -1.2 V	-0.2 A



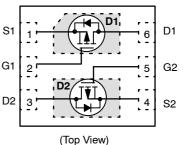
**MARKING** DIAGRAM WDFN6 **CASE 506AN** 

= Specific Device Code

= Date Code = Pb-Free Package

(Note: Microdot may be in either location)

### **PIN CONNECTIONS**



### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 3 of this data sheet.

## THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
SINGLE OPERATION (SELF-HEATED)			
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	83	
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ hetaJA}$	177	°C/W
Junction-to-Ambient – t ≤ 5 s (Note 3)	$R_{ heta JA}$	54	
DUAL OPERATION (EQUALLY HEATED)			
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	58	
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ heta JA}$	133 °C/V	
Junction-to-Ambient - t ≤ 5 s (Note 3)	$R_{ hetaJA}$	40	

Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
 Surface Mounted on FR4 Board using the minimum recommended pad size (30 mm², 2 oz Cu).

### MOSEET ELECTRICAL CHARACTERISTICS (T. - 25°C unless otherwise noted)

Parameter	Symbol	Test Condition	ıs	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -25$	50 μΑ	-12			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	$I_D = -250 \mu A$ , Ref to	25°C		-7.0		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		T <sub>J</sub> = 25°C			-1.0	μΑ
		$V_{DS} = -12 \text{ V}, V_{GS} = 0 \text{ V}$	T <sub>J</sub> = 85°C			-10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm$	8.0 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = -2$	50 μA	-0.35	-0.6	-0.8	V
Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				2.4		mV/°C
Drain-to-Source On-Resistance	rain-to-Source On-Resistance $R_{DS(on)}$ $V_{GS} = -4.5$ , $I_D = -3.0$ A		3.0 A		60	90	mΩ
		$V_{GS} = -2.5$ , $I_D = -3.0$ A			85	120	
		$V_{GS} = -1.8$ , $I_D = -0.7$ A			110	150	
		$V_{GS} = -1.5, I_D = -0.0$	0.5 A		140	200	
		$V_{GS} = -1.3, I_D = -0.0$	0.2 A		190		
		$V_{GS} = -1.2, I_D = -0.2$	0.2 A		230		
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -	3.0 A		6.0		S
CHARGES, CAPACITANCES AND GA	TE RESISTAN	CE					
Input Capacitance	C <sub>ISS</sub>				467		pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ N}$ $V_{DS} = -6.0 \text{ V}$	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -6.0 \text{ V}$		125		
Reverse Transfer Capacitance	C <sub>RSS</sub>	VDS0.0 V			79		
Total Gate Charge	Q <sub>G(TOT)</sub>				5.5	8.0	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	VG9 = -4.5 V. VD9 = 1	–6.0 V.		0.3		1
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = 100 \text{ N}$ $I_D = -3.0 \text{ A}$	,		0.8		1
Gate-to-Drain Charge	$Q_{GD}$	-			1.5		1

<sup>5.</sup> Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.

Gate Resistance

 $R_{G}$ 

12.2

Ω

<sup>6.</sup> Switching characteristics are independent of operating junction temperatures.

## $\textbf{MOSFET ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Parameter	Symbol	Test Condition	s	Min	Тур	Max	Unit	
SWITCHING CHARACTERISTICS (Note 6)								
Turn-On Delay Time	t <sub>d(ON)</sub>				6.6		ns	
Rise Time	t <sub>r</sub>	$V_{GS} = -4.5 \text{ V}, V_{DD} = -6.0 \text{ V},$ $I_{D} = -3.0 \text{ A}, R_{G} = 2.0 \Omega$			12.3			
Turn-Off Delay Time	t <sub>d(OFF)</sub>				14			
Fall Time	t <sub>f</sub>				16.2			
DRAIN-SOURCE DIODE CHARACTE	RISTICS							
Forward Recovery Voltage	$V_{SD}$	V 0V 1 10A	T <sub>J</sub> = 25°C		-0.7	-1.0	V	
		$V_{GS} = 0 \text{ V}, I_{S} = -1.0 \text{ A}$	T <sub>J</sub> = 85°C		-0.65			
Reverse Recovery Time	t <sub>RR</sub>		•		23	45	ns	
Charge Time	t <sub>a</sub>	$V_{GS} = 0 \text{ V, } d_{ SD}/d_t = 100 \text{ A/}\mu\text{s,} \\ I_S = -1.0 \text{ A}$			8.0			
Discharge Time	t <sub>b</sub>				15			
Reverse Recovery Time	$Q_{RR}$				10	20	nC	

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTLJD2104PTBG	WDFN6 (Pb-Free)	3000 / Tape & Reel
NTLJD2104PTAG	WDFN6 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

<sup>5.</sup> Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

### TYPICAL CHARACTERISTICS

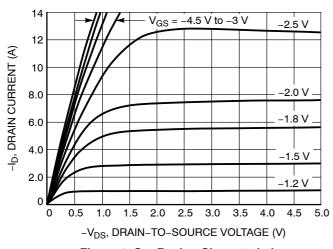


Figure 1. On-Region Characteristics

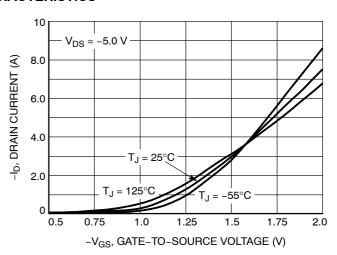


Figure 2. Transfer Characteristics

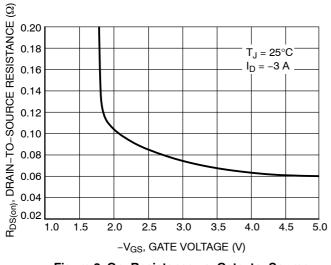


Figure 3. On-Resistance vs. Gate-to-Source Voltage

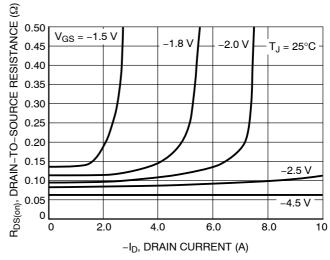


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

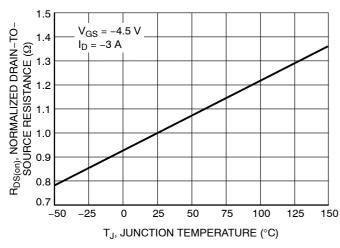


Figure 5. On–Resistance Variation with Temperature

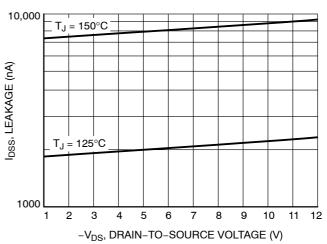


Figure 6. Drain-to-Source Leakage Current vs. Voltage

### TYPICAL CHARACTERISTICS

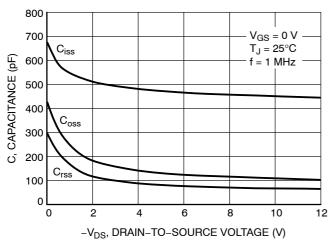
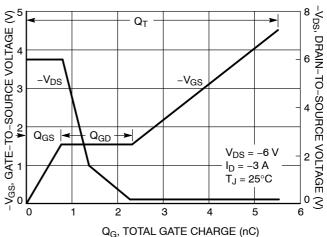
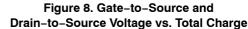


Figure 7. Capacitance Variation



QG, TOTAL GATE CHARGE (IIC)



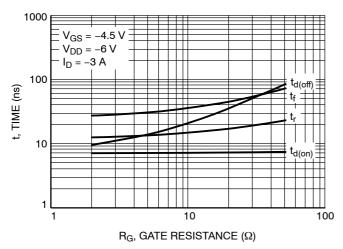


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

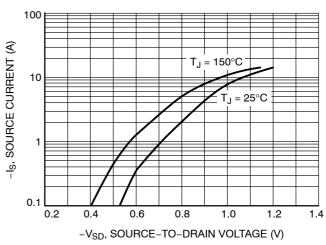


Figure 10. Diode Forward Voltage vs. Current

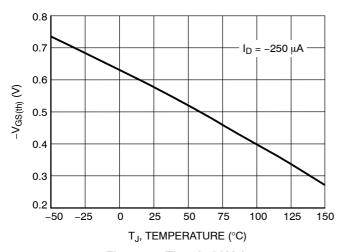


Figure 11. Threshold Voltage

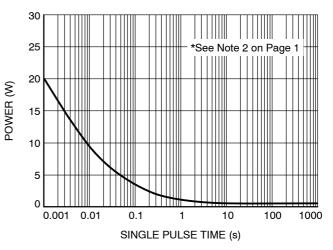


Figure 12. Single Pulse Maximum Power Dissipation

### **TYPICAL CHARACTERISTICS**

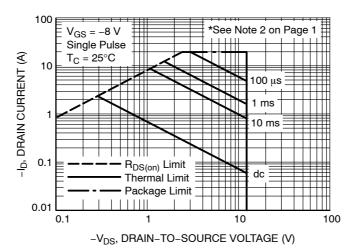


Figure 13. Maximum Rated Forward Biased Safe Operating Area

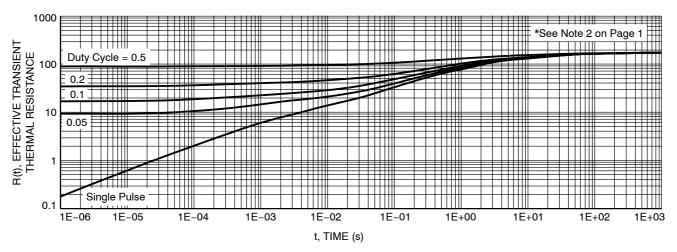
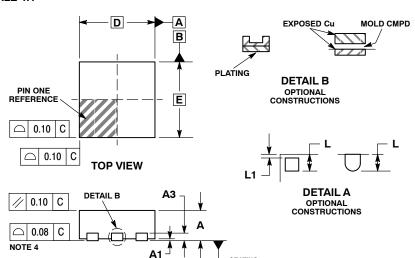


Figure 14. FET Thermal Response



### WDFN6 2x2, 0.65P CASE 506AN ISSUE G

**DATE 22 AUG 2013** 



⊕ 0.10 C A

D2

F

NOT	ES:
	D.11

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M. 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION & APPLIES TO PLATED
- DIMENSION DAPPLIES TO PLATED
  TERMINAL AND IS MEASURED BETWEEN
  0.15 AND 0.30 mm FROM THE TERMINAL TIP.
  COPLANARITY APPLIES TO THE EXPOSED
- PAD AS WELL AS THE TERMINALS.

	MILLIMETERS					
DIM	MIN	MAX				
Α	0.70	0.80				
A1	0.00	0.05				
A3	0.20	REF				
b	0.25	0.35				
D	2.00	BSC				
D2	0.57	0.77				
E	2.00 BSC					
E2	0.90	1.10				
е	0.65	BSC				
F	0.95	BSC				
K	0.25 REF					
L	0.20	0.30				
L1		0.10				

### **GENERIC MARKING DIAGRAM\***



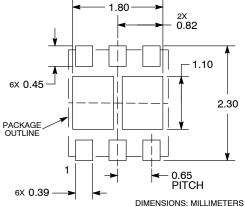
XX = Specific Device Code

Μ = Date Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

#### ⊕ 0.10 C A **SOLDERMASK DEFINED** MOUNTING FOOTPRINT Κ 6X b 0.10 | C | A е 0.05 C NOTE 3

SEATING PLANE



					0.03	U	NOILS
		BOTTOM	I VIEW				
STYLE 1	:	STYLE 2	2:	5	STYLE :	3:	
PIN 1.	SOURCE 1	PIN 1.	ANODE		PIN 1.	S	DURCE 1
2.	GATE 1	2.	N/C		2.	G/	ATE 1
3.	DRAIN 2	3.	DRAIN		3.	S	DURCE 2
4.	SOURCE 2	4.	SOURCE		4.	DF	RAIN 2
5.	GATE 2	5.	GATE		5.	G/	ATE 2
6.	DRAIN 1	6.	CATHODE		6.	DF	RAIN 1

**SIDE VIEW** 

D2

DETAIL A

DOCUMENT NUMBER:	OCUMENT NUMBER: 98AON20861D Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED		
DESCRIPTION:	WDFN6 2X2, 0.65P		PAGE 1 OF 1

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